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SUBSTITUTE SPECIFICATION

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TEMPERATURE COMPENSATED BANDGAP VOLTAGE REFERENCE

CROSS REFERENCE TO RELATED APPLICATIONS

This application is based on and claims priority of U.S. provisional patent application Serial No. 60/441,063, filed January 17, 2003, entitled TEMPERATURE COMPENSATED BANDGAP VOLTAGE REFERENCE, the entire disclosure of which is incorporated herein by reference.

BACKGROUND OF THE INVENTION

The present invention is directed to a temperature compensated bandgap voltage reference.

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Figure 1 shows how a reference voltage based upon V_{be} of a bipolar transistor can be obtained. The current source I is provided in the emitter path of a bipolar transistor. A plurality of current sources can be provided each coupled to an FET of varying size to provide current sources of different magnitude, e.g., I, 10I, etc. as shown.

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V_{be} of a bipolar transistor decreases with increasing temperature in a wellknown fashion. See Fig. 3. It is also known that a current mirror can be used to obtain a voltage representative of ΔV_{be} i.e., the difference between the V_{be} of two bipolar transistors. Figure 2 shows such a current mirror circuit. ΔV_{be} is equal to V_{be2} minus V_{be1} and ΔV_{be} is equal to kt/q ln NI/I. ΔV_{be} depends upon the ratio of the currents of the current sources as well as the temperature. In particular, ΔV_{be} increases with temperature. See Fig. 3. By combining the two circuits, it is possible to compensate V_{be} of a first transistor with ΔV_{be} obtained via two other transistors Q1

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